


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540022	<b>Applicant(s)/Patent Under Reexamination</b>  MIZUGUCHI ET AL.
	<b>Examiner</b>  SIU M LEE	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	342, 360, 316, 294, 359	4/9/2008	Siu M. Lee
329	304	4/9/2008	Siu M. Lee
327	248	4/9/2008	Siu M. Lee

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	4/9/2008	Siu M. Lee
Discuss the application with Chieh Fan	4/8/2008	Siu M. Lee

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner